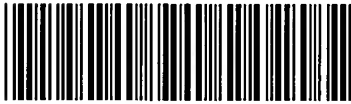


Search Notes

Application/Control No.

10/676,025

Examiner

Paul D. Kim

Applicant(s)/Patent under
Reexamination

YEOM ET AL.

Art Unit

3729

SEARCHED

Class	Subclass	Date	Examiner
29	603.03 729 737 757 759 760	6/13/2006	PK
360	98.07 98.0		
	99.08 99.1		
33	568 552 180		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text Search EAST/NPL (IEEE)	6/13/2006	PK
Reviewed Relative Application 10/676,144 10/676,145	6/13/2006	PK
Updated Text Search EAST	6/14/2006	PK
Updated Text Search EAST	12/5/2006	PK